




# EMF Exposure Report

Test Report No..... :	TCT250916E037	
Date of issue..... :	Oct. 14, 2025	
Testing laboratory .....	Shenzhen TCT Testing Technology Co., Ltd.	
Testing location/ address:	2101 & 2201, Zhenchang Factory, Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China	
Applicant's name..... :	Shenzhen Huafurui Technology Co., Ltd.	
Address..... :	Unit 601-03, 6/F, Block A, Building 1, Ganfeng Technology Building, No. 993 Jiaxian Road, Xiangjiaotang Community, Bantian Street, Longgang District, Shenzhen, P.R. China	
Manufacturer's name ... :	Shenzhen Huafurui Technology Co., Ltd.	
Address..... :	Unit 601-03, 6/F, Block A, Building 1, Ganfeng Technology Building, No. 993 Jiaxian Road, Xiangjiaotang Community, Bantian Street, Longgang District, Shenzhen, P.R. China	
Standard(s) .....	EN 50663:2017; EN 62479:2010	
Product Name..... :	Smartphone	
Trade Mark .....	CUBOT	
Model/Type reference..... :	KINGKONG ACE 5	
Rating(s)..... :	Refer to EUT description of page 3	
Date of receipt of test item .....	Sep. 16, 2025	
Date (s) of performance of test..... :	Sep. 16, 2025 ~ Oct. 14, 2025	
Tested by (+signature) ... :	Rleo LIU	
Check by (+signature).... :	Beryl ZHAO	
Approved by (+signature):	Tomsin	

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## 1. General Product Information

### 1.1. EUT description

Product Name.....:	Smartphone
Model/Type reference.....:	KINGKONG ACE 5
Hardware Version.....:	G2510T-UF-V1.0
Software Version .....	CUBOT_KINGKONG_ACE_5_F101_V1.0
Operation Frequency .....	2402MHz~2480MHz
Modulation Technology .....	For BT: GFSK, $\pi/4$ -DQPSK, 8DPSK For BLE: GFSK
Antenna Type.....:	FPC Antenna
Antenna Gain.....:	0.05dBi
Rating(s).....:	Adapter Information1: Model: HJ-PD33W-EU Input: AC 100-240V, 50/60Hz, 0.8A Output: DC 5.0V, 3.0A, 15.0W OR DC 9.0V, 3.0A, 27.0W OR DC 12.0V, 2.75A, 33.0W MAX Adapter Information2: Model: TD-203G2000170VF01 Input: AC 100-240V, 50/60Hz, 0.6A Output: DC 5V, 3A/ DC 9V, 3 A/ DC 12V, 2.5A/ DC 15V, 2A/ DC 20V, 1.5A PPS: DC 3.3-16V, 2A/ DC 3.3-11V, 3A Total Output Power: 33W Max Rechargeable Li-ion Battery DC 3.87V

Note: The antenna gain listed in this report is provided by applicant, and the test laboratory is not responsible for this parameter.

### 1.2. Model(s) list

None.

## 2. General Information

### 2.1. Test environment and mode

Item	Normal condition
Temperature	+25°C
Voltage	DC 3.87V
Humidity	56%
Atmospheric Pressure:	1008 mbar
Test Mode:	
Transmitting Mode:	Keep the EUT in transmitting mode with modulation.

### 2.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
/	/	/	/	/

**Note:**

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

### 2.3. Test Instruments List

Conducted Emission				
Name	Model No.	Manufacturer	Date of Cal.	Due Date
Spectrum Analyzer	N9020A	Agilent	Jan. 21, 2025	Jan. 20, 2026
Signal Generator	N5182A	Agilent	Jan. 21, 2025	Jan. 20, 2026

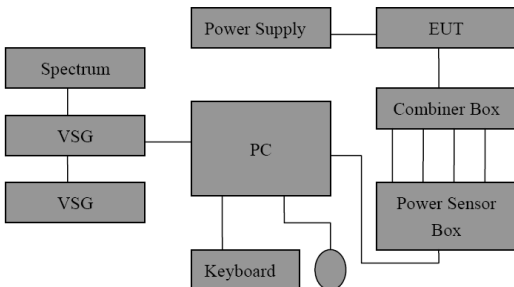
## 3. Test Facilities

Shenzhen TCT Testing Technology Co., Ltd.

Address: 2101 & 2201, Zhenchang Factory, Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China

TEL: +86-755-27673339

## 4. Technical Requirements Specification

<b>Test Requirement:</b>	EN 50663		
<b>Limit:</b>	Exposure tier	Region of body	P <sub>max</sub> (mW)
	General public	Head and trunk	20
		Limbs	40
<b>Test Setup:</b>	 <pre> graph TD     PS[Power Supply] --&gt; EUT[EUT]     EUT --&gt; CB[Combiner Box]     CB --&gt; PSB[Power Sensor Box]     PC[PC] --&gt; PS     PC --&gt; S[Spectrum]     PC --&gt; VSG1[VSG]     PC --&gt; VSG2[VSG]     PC --&gt; K[Keyboard]     PC --&gt; PSB     </pre>		
<b>Test Procedure</b>	<p><b>Step 1:</b> Use a fast power sensor suitable for 2,4 GHz and capable of 1 MS/s. Use the following settings:</p> <ul style="list-style-type: none"> <li>- Sample speed 1 MS/s or faster.</li> <li>- The samples must represent the power of the signal.</li> <li>- Measurement duration: For non-adaptive equipment: equal to the observation period defined in clauses 4.3.1.2.1 or 4.3.2.3.1. For adaptive equipment, the measurement duration shall be long enough to ensure a minimum number of bursts (at least 10) are captured.</li> </ul> <p><b>Note 1:</b> For adaptive equipment, to increase the measurement accuracy, a higher number of bursts may be used.</p> <p><b>Step 2:</b> For conducted measurements on devices with one transmit chain: -Connect the power sensor to the transmit port, sample the transmit signal and store the raw data. Use these stored samples in all following steps. For conducted measurements on devices with multiple transmit chains: -Connect one power sensor to each transmit port for a synchronous measurement on all transmits ports. -Trigger the power sensors so that they start sampling at the same time. Make sure the time difference between the samples of all sensors is less than half the time between two samples. -For each instant in time, sum the power of the individual samples of all ports and store them. Use these stored samples in all following steps.</p> <p><b>Step 3:</b></p>		

	<p>Find the start and stop times of each burst in the stored measurement samples.</p> <p><b>Note 2:</b> The start and stop times are defined as the points where the power is at least 20 dB below the RMS burst power calculated in step 4.</p> <p><b>Step 4:</b></p> <p>Between the start and stop times of each individual burst calculate the RMS power over the burst. Save these Pburst values, as well as the start and stop times for each burst.</p> <p><b>Step 5:</b></p> <p>The highest of all Pburst values (value "A" in dBm) will be used for maximum e.i.r.p. calculations.</p> <p><b>Step 6:</b></p> <p>Add the (stated) antenna assembly gain "G" in dBi of the individual antenna.</p> <p>If applicable, add the additional beamforming gain "Y" in dB.</p> <p>If more than one antenna assembly is intended for this power setting, the maximum overall antenna gain (G or G + Y) shall be used.</p> <p>The RF Output Power (P) shall be calculated using the formula below:</p> $P = A + G + Y$
<b>Test Instrument:</b>	Refer to section 2.3 for details
<b>Test Mode:</b>	Refer to section 2.1 for details
<b>Test Results:</b>	PASS

## 4.1.1. Test Data

For BDR+EDR:

Maximum Emissions Level				
Modulation	EIRP Level (dBm)	EIRP Level(mW)	Limit (mW)	Result
GFSK	6.56	4.53	20	PASS
Pi/4 DQPSK	4.09	2.56		
8DPSK	4.25	2.66		

For BLE(1M):

Maximum Emissions Level				
Frequency (MHz)	EIRP Level (dBm)	EIRP Level(mW)	Limit (mW)	Result
GFSK Mode				
2402	4.45	2.79	20	PASS
2440	4.64	2.91		
2480	3.91	2.46		

For BLE(2M):

Maximum Emissions Level				
Frequency (MHz)	EIRP Level (dBm)	EIRP Level(mW)	Limit (mW)	Result
GFSK Mode				
2404	3.50	2.24	20	PASS
2440	4.39	2.75		
2478	4.56	2.86		

**Note:** PASS means EUT complies with the essential requirements in the standard.

\*\*\*\*\***END OF REPORT**\*\*\*\*\*